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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Jonathan Shekter

Art Unit : 2613

Serial No.: 10/080,525 Filed: February 21. Examiner : Unknown

Filed : February 21, 2002 Title : COMPOSITE REN

: COMPOSITE RENDERING 3-D GRAPHICAL OBJECTS

Commissioner for Patents Washington, D.C. 20231

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## INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449, copies of which are enclosed. A copy of a communication from a foreign patent office in a counterpart application is also enclosed.

This statement is being filed before the receipt of a first Office action on the merits. No fee is required. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted.

Date: October 3, 2002

Tim H. Pham Reg. No. 48,589

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## CERTIFICATE OF MAILING BY FIRST CLASS MAIL

I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, Washington, D.C. 20231.

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Substitute form PTO-1449 (Modified)

U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 07844-499001

February 21, 2002

Application No. 10/080,525

Information Disclosure Statement by Applicant (Use several sheets if necessary)

Jonathan Shekter

Group Art Unit 2613

(37 CFR §1.98(b))

			U.S. Pate	ent Documents			
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	6,016,150	Jan. 18, 2000	Lengyel et al.			
	AB	6,229,553	May 8, 2001	Duluk, Jr. et al.			
	AC	6,064,393	May 16, 2000	Lengyel et al.			
	AD						
	AE						
	AF					BEC	EIVED
	AG					207	EIVED 0 2002
	AH					001-1	0 2002
	ΑI					Technology	Center 2600
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Translation	
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)					
Examiner	Desig.				
· Initial	ID	Document			
	AQ				
	AR				
	AS				
	AT				

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EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.